

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY. DOCKET NO. M122-1299	SERIAL NO. 09/428,125
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)					APPLICANT Vishna K. Agarwal et al.	
					FILING DATE October 26, 1999	GROUP 2822
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*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
KR	AA	5,580,812	12/96	Ikemaru et al.		
	AB					
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FOREIGN PATENT DOCUMENTS						
	Document Number	Date	Country	Class	Subclass	Translation
						Yes No
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EXAMINER			DATE CONSIDERED			
K. A. Rose			1/8/03			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>						

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-1299		SERIAL NO. 09/428,123	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Vishnu K. Agarwal et al.			
				FILING DATE October 26, 1999		GROUP 2822	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
KP	AA	5,913,125	06/99	Broellienne et al.			
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K. Rose			11/8/03				
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<div style="display: flex; align-items: center; justify-content: center;"> <div style="border: 2px solid black; border-radius: 50%; padding: 10px; text-align: center; margin-right: 10px;"> O I P E JAN 18 2002 PATENT & TRADEMARK OFFICE </div> <div> LIST OF ART CITED BY APPLICANT (Use several sheets if necessary) </div> </div>				APPLICANT Vishnu K. Agarwal et al.			
				FILING DATE October 26, 1999		GROUP 2822	
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RR	AA 5,452,178	09/1995	Emesh et al.	361/	303		
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Oct. 26, 1999 [RCE Filed Herewith]GROUP
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	AC	5,557,122	09/96	Shrivastava et al.			
	AD	5,930,106	07/99	Deboer et al.			
	AE	6,201,728 B1	03/01	Narui et al.			
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	AG	4,873,610	10/89	Shimizu et al.			
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	AI	6,096,597	08/00	Tsu et al.			
	AJ	5,192,871	03/93	Ramakrishnan et al.			
	AK	3,210,607	10/65	Flanagan			
	AL	6,282,080 B1	08/01	DeBoer et al.			
✓	AM	5,943,580	08/99	Ramakrishnan			
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							Yes	No
KR	AO	WO 97/44797	11/97	PCT				X
	AP							

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)

KR	AO	IBM Technical Disclosure Bulletin: "Process for Selective Etching of Tantalum Oxide", Vol. 27, No. 12, May 1985, one page.
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	AS	

EXAMINER

H. J. Rose

DATE CONSIDERED

1/8/03

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KR	AA	App. S/N 09/512,149		Agarwal			02/23/00
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